## Georg Haberfehlner

List of Publications by Year in descending order

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#	Article	IF	CITATIONS
1	3D nanoscale elemental mapping of precipitates in steel: Evaluation of analytical electron tomography and comparison to atom probe tomography. Micron, 2022, 156, 103233.	2.2	0
2	Benefits of direct electron detection and PCA for EELS investigation of organic photovoltaics materials. Micron, 2021, 140, 102981.	2.2	11
3	Three-dimensional vectorial imaging of surface phonon polaritons. Science, 2021, 371, 1364-1367.	12.6	39
4	Three dimensional vectorial imaging of surface phonon polaritons. Microscopy and Microanalysis, 2021, 27, 698-699.	0.4	0
5	Chemical homogeneity and optical properties of individual sodium tungsten bronze nanocubes. Micron, 2020, 139, 102926.	2.2	4
6	New Solar Cell–Battery Hybrid Energy System: Integrating Organic Photovoltaics with Li-Ion and Na-Ion Technologies. ACS Sustainable Chemistry and Engineering, 2020, 8, 19155-19168.	6.7	14
7	Study on Ca Segregation toward an Epitaxial Interface between Bismuth Ferrite and Strontium Titanate. ACS Applied Materials & Interfaces, 2020, 12, 12264-12274.	8.0	5
8	Elemental Nanoanalysis of Interfacial Alumina–Aryl Fluoride Interactions in Fullereneâ€Free Organic Tandem Solar Cells. Advanced Materials Interfaces, 2019, 6, 1901053.	3.7	8
9	Elucidation of Donor:Acceptor Phase Separation in Nonfullerene Organic Solar Cells and Its Implications on Device Performance and Charge Carrier Mobility. ACS Applied Energy Materials, 2019, 2, 7535-7545.	5.1	11
10	Analyzing the Nanogranularity of Focused-Electron-Beam-Induced-Deposited Materials by Electron Tomography. ACS Applied Nano Materials, 2019, 2, 5356-5359.	5.0	9
11	In situ real-time annealing of ultrathin vertical Fe nanowires grown by focused electron beam induced deposition. Acta Materialia, 2019, 174, 379-386.	7.9	17
12	Total generalized variation regularization for multi-modal electron tomography. Nanoscale, 2019, 11, 5617-5632.	5.6	27
13	Correlation between sputter deposition parameters andl-Vcharacteristics in double-barrier memristive devices. Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics, 2019, 37, 061203.	1.2	14
14	In situ atomic-scale observation of oxidation and decomposition processes in nanocrystalline alloys. Nature Communications, 2018, 9, 946.	12.8	14
15	Diffusion-defining atomic-scale spinodal decomposition within nanoprecipitates. Nature Materials, 2018, 17, 1101-1107.	27.5	43
16	3D Imaging of Gap Plasmons in Vertically Coupled Nanoparticles by EELS Tomography. Nano Letters, 2017, 17, 6773-6777.	9.1	31
17	In depth nano spectroscopic analysis on homogeneously switching double barrier memristive devices. Journal of Applied Physics, 2017, 121, 245307.	2.5	14
18	Tomographic imaging of the photonic environment of plasmonic nanoparticles. Nature Communications, 2017, 8, 37.	12.8	51

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19	Quantitative EDXS: Influence of geometry on a four detector system. Ultramicroscopy, 2017, 172, 30-39.	1.9	17
20	Synthesis and morphology of iron–iron oxide core–shell nanoparticles produced by high pressure gas condensation. Nanotechnology, 2016, 27, 215703.	2.6	19
21	Synthesis of nanoparticles in helium droplets—A characterization comparing mass-spectra and electron microscopy data. Journal of Chemical Physics, 2015, 143, 134201.	3.0	52
22	Analytical Electron Tomography: Methods and Applications. Microscopy and Microanalysis, 2015, 21, 2171-2172.	0.4	0
23	Impact of nucleation conditions on diameter modulation of GaAs nanowires. Nanotechnology, 2015, 26, 225604.	2.6	5
24	Formation of bimetallic clusters in superfluid helium nanodroplets analysed by atomic resolution electron tomography. Nature Communications, 2015, 6, 8779.	12.8	90
25	Correlated 3D Nanoscale Mapping and Simulation of Coupled Plasmonic Nanoparticles. Nano Letters, 2015, 15, 7726-7730.	9.1	35
26	Nanoscale voxel spectroscopy by simultaneous EELS and EDS tomography. Nanoscale, 2014, 6, 14563-14569.	5.6	71
27	3D spatial resolution improvement by dual-axis electron tomography: Application to tri-gate transistors. Ultramicroscopy, 2014, 136, 144-153.	1.9	8
28	3D analysis of advanced nano-devices using electron and atom probe tomography. Ultramicroscopy, 2014, 136, 185-192.	1.9	52
29	Controlled Modulation of Diameter and Composition along Individual III–V Nitride Nanowires. Nano Letters, 2013, 13, 331-336.	9.1	69
30	Selenium Segregation in Femtosecond-Laser Hyperdoped Silicon Revealed by Electron Tomography. Microscopy and Microanalysis, 2013, 19, 716-725.	0.4	10
31	Development of Porosimetry Techniques for the Characterization of Plasma-Treated Porous Ultra Low-k Materials. ECS Transactions, 2011, 35, 729-746.	0.5	1
32	Thermal imaging of smart power DMOS transistors in the thermally unstable regime using a compact transient interferometric mapping system. Microelectronics Reliability, 2009, 49, 1346-1351.	1.7	11